Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/814,886	HANCHER ET AL.	
Examiner	Art Unit	
John P. Lacyk	3735	

SEARCHED				
Class	Subclass	Date	Examiner	
600	9-15			
128	897-899			
623	17.11,			
	23.64,			
	23.72,			
	23.76,			
	925			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Plus search	1/14/200	5 JPL
East search	6/24/2000	6 JPL